

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	50	("5940870" "6154765" "5682512" "5805572" "5428803" "6069986" "6163855" "6665278" "6175931" "5832182" "6748429" "6175574" "6049889" "6332180" "6047323" "6295585" "5625831" "6856621" "5191578" "6332165" "6370585" "6449700" "6536000" "5887134" "5946685" "6047332" "6163806" "6119143" "6151688" "5652841" "6173374" "6338112" "6353898" "6594786" "6249802" "6389451" "6801937" "5224100" "5404451" "6014669" "5561784" "6438705" "6182197" "6769008" "6862613" "5612865" "5699500" "5727206" "6006098" "6253230").pn.	USPAT	OR	ON	2005/06/15 15:32
L2	1	"6185203".pn.	USPAT	OR	ON	2005/06/15 14:42
L3	7	("5856974" "5991817" "6636498" "6389023" "6779039" "6577634" "6078963").pn.	USPAT	OR	ON	2005/06/15 14:43
L4	8	("5856974" "5991817" "6636498" "6389023" "6779039" "6577634" "6078963" "6185203").pn.	USPAT	OR	ON	2005/06/15 14:56
L5	1	"6,674,756".pn.	USPAT	OR	ON	2005/06/15 14:56
L6	18	1 and (network near4 address)	USPAT	OR	ON	2005/06/15 15:34
S2	1	"5856974".pn.	USPAT	OR	ON	2005/05/20 09:24
S4	21	("5856974" "5991817" "6636498" "6389023" "6779039" "6577634" "5640399" "6151688" "6608830" "6769008" "6078963" "5574849" "5751932" "5185560" "5282270" "5546540" "5745699" "5751932" "5781534" "6286047" "6426947" "6826172").pn.	USPAT	OR	ON	2005/06/15 07:37
S5	13	("5856974" "5991817" "6636498" "6389023" "6779039" "6577634" "5640399" "6151688" "6608830" "6769008" "6078963" "5574849" "5751932").pn.	USPAT	OR	ON	2005/06/15 07:39
S6	6795	mask near2 register	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/15 08:39

S7	4830	mask adj register	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/15 08:39
S8	1013	S7 and ("709" "370").clas	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/15 08:39
S9	575	S7 and ("709" "370").clas.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/15 08:40
S10	136	S9 and (network near2 address\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/15 08:49
S11	2	"5856974".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/15 13:02


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